

# AP5322GM-HF-VB Datasheet N-Channel 100 V (D-S) MOSFET

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)	
100	0.200 at V <sub>GS</sub> = 10 V	3	7.3 nC	

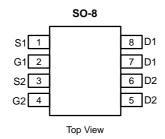
#### **FEATURES**

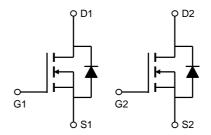
- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- 100 % R<sub>a</sub> and UIS Tested
- Compliant to RoHS Directive 2002/95/EC



### **APPLICATIONS**

- DC/DC Conversion
  - Notebook System Power





Absolute Maximum Ratings T <sub>A</sub> =25℃ unless otherwise noted					
Parameter		Symbol	Maximum	Units	
Drain-Source Voltage	е	$V_{DS}$	100	V	
Gate-Source Voltage		$V_{GS}$	±20	V	
Continuous Drain	T <sub>A</sub> =25℃		3.0		
Current	T <sub>A</sub> =70℃	'D	2.5	Α	
Pulsed Drain Current C		I <sub>DM</sub>	10		
Avalanche Current <sup>C</sup>		I <sub>AR</sub>	2	A	
Repetitive avalanche energy L=0.1mH <sup>C</sup>		E <sub>AR</sub>	12.8	mJ	
Power Dissipation <sup>B</sup>	T <sub>A</sub> =25℃	В	2	W	
	T <sub>A</sub> =70℃	$-P_{D}$	1.3	v	
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	C	

Thermal Characteristics					
Parameter	Symbol	Тур	Max	Units	
Maximum Junction-to-Ambient A	t ≤ 10s	D	48	62.5	℃/W
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	74	90	€\M
Maximum Junction-to-Lead	Steady-State	$R_{\theta JL}$	32	40	℃/W

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#### Electrical Characteristics (T<sub>J</sub>=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units	
STATIC F	STATIC PARAMETERS						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	100			V	
	Zero Gate Voltage Drain Current	V <sub>DS</sub> =80V, V <sub>GS</sub> =0V			1	μΑ	
I <sub>DSS</sub>	Zero Gate Voltage Brain Gurrent	T <sub>J</sub> =55℃			5	μΑ	
$I_{GSS}$	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ = ±30V			100	nA	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$	1	2	3	V	
$I_{D(ON)}$	On state drain current	$V_{GS}$ =10V, $V_{DS}$ =5V	5			Α	
R	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =2.5A		200		mO	
R <sub>DS(ON)</sub>	Static Drain-Source On-Nesistance	T <sub>J</sub> =125℃		253		mΩ	
<b>g</b> FS	Forward Transconductance	$V_{DS}$ =5V, $I_D$ =2.5A		15		S	
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =1A,V <sub>GS</sub> =0V		0.77	1	V	
I <sub>S</sub>	Maximum Body-Diode Continuous Curr	num Body-Diode Continuous Current			2.5	Α	
I <sub>SM</sub>	Pulsed Body-diode Current <sup>C</sup>				18	Α	
DYNAMIC	PARAMETERS						
C <sub>iss</sub>	Input Capacitance		510	740	970	pF	
C <sub>oss</sub>	Output Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =40V, f=1MHz	28	40	52	pF	
$C_{rss}$	Reverse Transfer Capacitance		12	20	30	pF	
$R_g$	Gate resistance	$V_{GS}$ =0V, $V_{DS}$ =0V, f=1MHz	0.9	1.8	2.7	Ω	
SWITCHING PARAMETERS							
Q <sub>g</sub> (10V)	Total Gate Charge		8	11	13	nC	
Q <sub>g</sub> (4.5V)	Total Gate Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =40V, I <sub>D</sub> =2.5A	4	5.5	7		
$Q_{gs}$	Gate Source Charge	V <sub>GS</sub> -10V, V <sub>DS</sub> -40V, I <sub>D</sub> -2.3A	4	5	6	nC	
$Q_{gd}$	Gate Drain Charge	7	0.7	1.2	1.7	nC	
t <sub>D(on)</sub>	Turn-On DelayTime			7.2		ns	
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =40V, $R_L$ =8 $\Omega$ ,		2.2		ns	
t <sub>D(off)</sub>	Turn-Off DelayTime	$R_{GEN}=3\Omega$		17		ns	
t <sub>f</sub>	Turn-Off Fall Time	7		2		ns	
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =2.5A, dI/dt=300A/μs	14	20	26	ns	
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =2.5A, dI/dt=300A/μs	35	50	65	nC	

A. The value of  $R_{\theta JA}$  is measured with the device mounted on  $1\text{in}^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A$  =25°C. The value in any given application depends on the user's specific board design.

B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =150°C, using  $\leq$  10s junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}=150$ °C. Ratings are based on low frequency and duty cycles to keep initial  $T_J=25$ °C.

D. The  $R_{\theta JA}$  is the sum of the thermal impedence from junction to lead  $R_{\theta JL}$  and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on 1in<sup>2</sup> FR-4 board with



#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

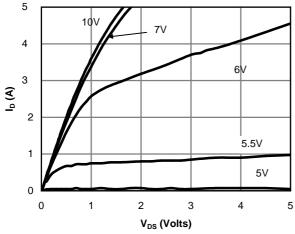


Fig 1: On-Region Characteristics (Note E)

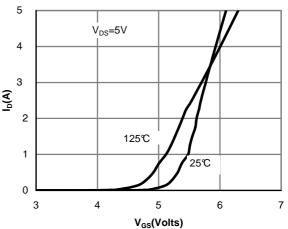


Figure 2: Transfer Characteristics (Note E)

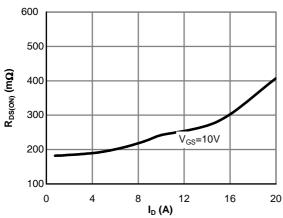


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

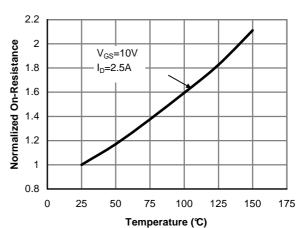


Figure 4: On-Resistance vs. Junction Temperature (Note E)

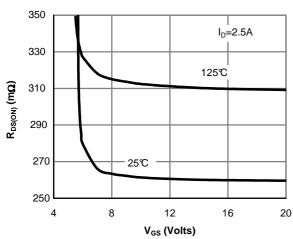


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

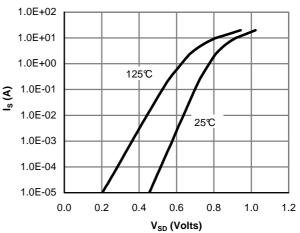


Figure 6: Body-Diode Characteristics (Note E)

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#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

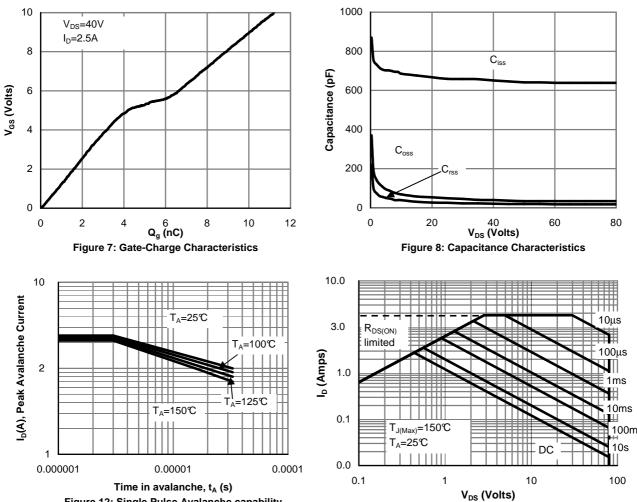


Figure 12: Single Pulse Avalanche capability

Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

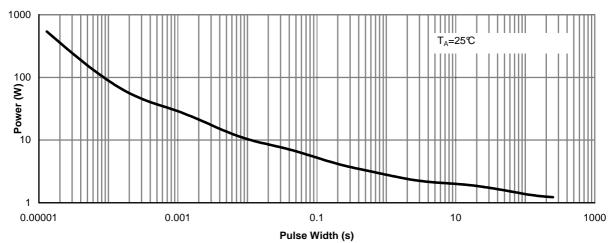


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note F)



### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

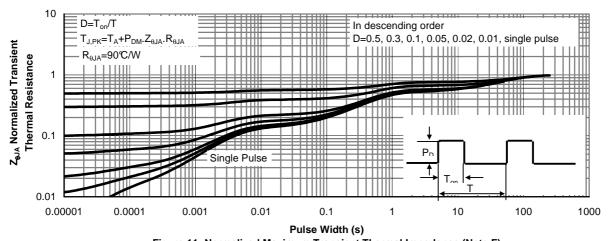
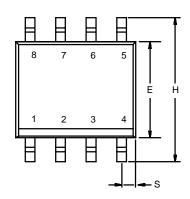
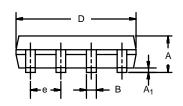


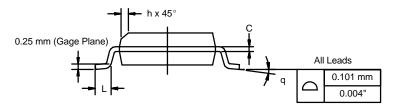
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



**SOIC (NARROW): 8-LEAD**JEDEC Part Number: MS-012







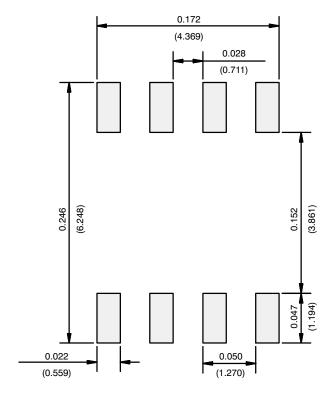
	MILLIMETERS		INC	HES	
DIM	Min	Max	Min	Max	
Α	1.35	1.75	0.053	0.069	
A <sub>1</sub>	0.10	0.20	0.004	0.008	
В	0.35	0.51	0.014	0.020	
С	0.19	0.25	0.0075	0.010	
D	4.80	5.00	0.189	0.196	
E	3.80	4.00	0.150	0.157	
е	1.27	BSC	0.050 BSC		
Н	5.80	6.20	0.228	0.244	
h	0.25	0.50	0.010	0.020	
L	0.50	0.93	0.020	0.037	
q	0°	8°	0°	8°	
S	0.44	0.64	0.018	0.026	
FCN: C-06527-Rev I 11-Sen-06					

ECN: C-06527-Rev. I, 11-Sep-06

DWG: 5498



## **RECOMMENDED MINIMUM PADS FOR SO-8**



Recommended Minimum Pads Dimensions in Inches/(mm)



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